P-Channel 1.8V Specified POWERTRENCH® MOSFET

Description

This P-Channel 1.8 V specified MOSFET is a rugged gate version of ON Semiconductor's advanced POWERTRENCH process. It has been optimized for power management applications with a wide range of gate drive voltage (1.8 V-8~V).

Features

- -13.5 A, -20 V
 - $R_{DS(ON)} = 8.5 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$
 - $R_{DS(ON)} = 10.5 \text{ m}\Omega$ @ $V_{GS} = -2.5 \text{ V}$
 - $R_{DS(ON)} = 14 \text{ m}\Omega @ V_{GS} = -1.8 \text{ V}$
- Fast Switching Speed
- High Performance Trench Technology for Extremely Low R_{DS(ON)}
- High Current and Power Handling Capability

Applications

- Power Management
- Load Switch
- Battery Protection

Specifications

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

| Symbol | Parameter | | Value | Unit |
|-----------------------------------|---|----------------------|-------------|------|
| V_{DSS} | Drain-to-Source Voltage | | -20 | ٧ |
| V_{GSS} | Gate-to-Source Voltage | | ±8 | ٧ |
| I _D | Drain Current | Continuous (Note 1a) | -13.5 | Α |
| | | Pulsed | -50 | |
| P _D | Power Dissipation | (Note 1a) | 2.5 | W |
| | | (Note 1b) | 1.5 | |
| | | (Note 1c) | 1.2 | |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to +175 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

| Symbol | Parameter | Value | Unit |
|----------------|--|-------|------|
| $R_{	heta JA}$ | Thermal Resistance, Junction-to-Ambient (Note 1a) | 50 | °C/W |
| $R_{	heta JA}$ | Thermal Resistance, Junction-to-Ambient (Note 1c) | 125 | °C/W |
| $R_{	heta JC}$ | Thermal Resistance, Junction-to-Ambient (Note 1) | 25 | °C/W |

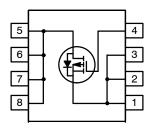


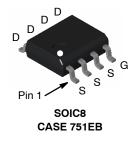
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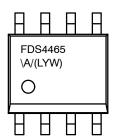
| V _{DSS} | R _{DS(on)} MAX | I _{D MAX} |
|------------------|--------------------------|--------------------|
| -20 V | 8.5 mΩ @ -4.5 V | –13.5 A |
| | 10.5 m Ω @ –2.5 V | |
| | 14 mΩ @ –1.8 V | |

P-Channel





MARKING DIAGRAM



A L YW FDS4465 = Assembly Site

= Wafer Lot Number

= Assembly Start Week = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

| Symbol | Parameter | Test Condition | | Min | Тур | Max | Unit |
|----------------------------------|---|---|-------------------------|------|------|------|-------|
| OFF CHARA | ACTERISTICS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 250$ |) μΑ | -20 | | | V |
| $\Delta BV_{DSS} \ \Delta T_{J}$ | Breakdown Voltage Temperature Coefficient | I _D = -250 μA, Reference | d to 25°C | | -12 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = -16 V, V _{GS} = | 0 V | | | -1 | μΑ |
| I _{GSSF} | Gate-Body Leakage, Forward | V _{GS} = 8 V, V _{DS} = 0 | O V | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage, Reverse | $V_{GS} = -8 \text{ V}, V_{DS} =$ | 0 V | | | -100 | nA |
| ON CHARA | CTERISTICS (Note 2) | | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250$ | Ο μΑ | -0.4 | -0.6 | -1.5 | V |
| $\Delta V_{GS(th)} \ \Delta T_J$ | Gate Threshold Voltage Temperature Coefficient | I _D = -250 μA, Reference | d to 25°C | | 3 | | mV/°C |
| R _{DS(on)} | Static Drain-Source On-Resistance | $V_{GS} = -4.5 \text{ V}, I_D = -13.5 \text{ A}$ | | | 6.7 | 8.5 | mΩ |
| | | $V_{GS} = -2.5 \text{ V}, I_D = -12 \text{ A}$ | | | 8.0 | 10.5 | |
| | | $V_{GS} = -1.8 \text{ V}, I_D = -10.5 \text{ A}$ | | | 9.8 | 14 | |
| | | $V_{GS} = -4.5 \text{ V}, I_D = -13.5 \text{ A}$ | T _J = 125°C | | 9.0 | 13 | |
| I _{D(on)} | On-State Drain Current | V _{GS} = -4.5 V, V _{DS} = | –5 V | -50 | | | Α |
| 9FS | Forward Transconductance | $V_{DS} = -5 \text{ V}, I_D = -13$ | 3.5 A | | 70 | | S |
| OYNAMIC C | HARACTERISTICS | | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f$ | = 1.0 MHz | | 8237 | | pF |
| C _{oss} | Output Capacitance |] | | | 1497 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | | 750 | | pF |
| R_g | Gate Resistance | | | 0.1 | 3.0 | 6.0 | Ω |
| WITCHING | CHARACTERISTICS (Note 2) | | | | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = -10 \text{ V}, I_{D} = -1 \text{ A}, V_{G}$ $R_{GEN} = 6 \Omega$ | _{as} = -4.5 V, | | 20 | 36 | ns |
| t _r | Turn-On Rise Time | $H_{GEN} = 6 \Omega$ | | | 24 | 38 | ns |
| t _{d(off)} | Turn-Off Delay Time | 1 | | | 300 | 480 | ns |
| t _f | Turn-Off Fall Time | 1 | | | 140 | 224 | ns |
| Qg | Total Gate Charge | $V_{DS} = -10 \text{ V}, I_D = -1 \text{ A}, V_C$ | _{SS} = -4.5 V | | 86 | 120 | nC |
| Q _{gs} | Gate-Source Charge |] | | | 20 | | nC |
| Q_{gd} | Gate-Drain Charge | | | | 11 | | nC |
| RAIN-SOL | IRCE DIODE CHARACTERISTICS AND | MAXIMUM RATINGS | | _ | | | |
| IS | Maximum Continuous Drain-Source Did | ode Forward Current | | | | -2.1 | Α |
| V _{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_{S} = -2.1 \text{ A}$ | (Note 2) | | -0.6 | -1.2 | V |
| | • | • | | | • | _ | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

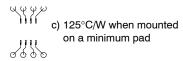
^{1.} $R_{\theta,JA}$ is the sum of the junction–to–case and case–to–ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



 a) 50°C/W when mounted on a 1 in² pad of 2 oz copper



b) 105°C/W when mounted on a .04 in² pad of 2 oz copper



Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

TYPICAL CHARACTERISTICS

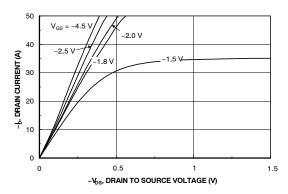


Figure 1. On-Region Characteristics

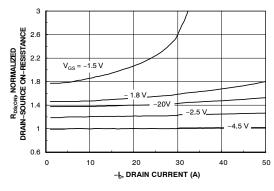


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage

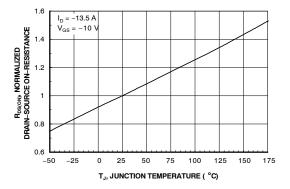


Figure 3. On–Resistance Variation with Temperature

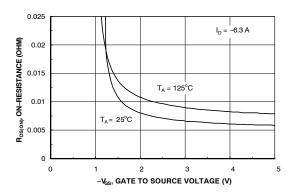


Figure 4. On–Resistance Variation with Gate–to–Source Voltage

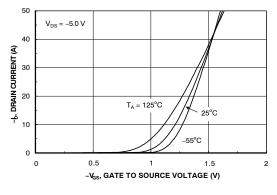


Figure 5. Transfer Characteristics

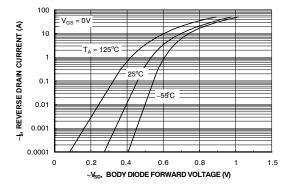


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

TYPICAL CHARACTERISTICS

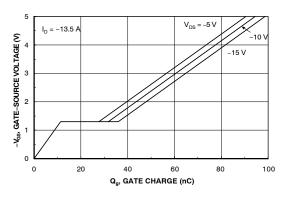
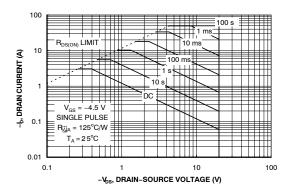


Figure 7. Gate Charge Characteristics

Figure 8. Capacitance Characteristics



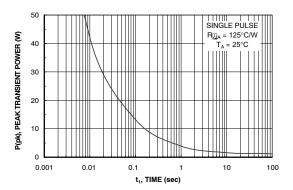


Figure 9. Maximum Safe Operating Area

Figure 10. Single Pulse Maximum Power Dissipation

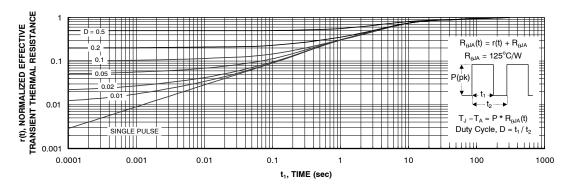


Figure 11. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1c.

Transient thermal response will change depending on circuit board design.

PACKAGE MARKING AND ORDERING INFORMATION

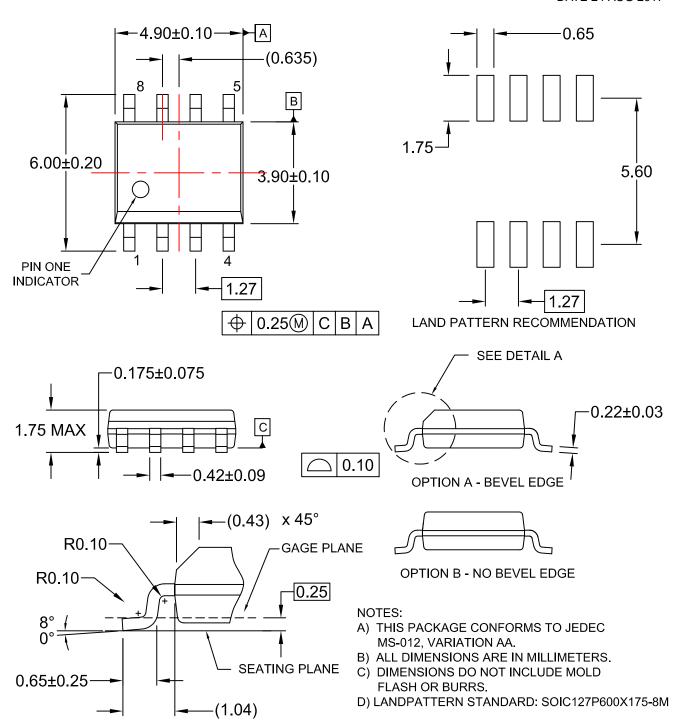
| Device Marking | Device | Reel Size | Tape Width | Shipping [†] |
|----------------|---------|-----------|------------|-----------------------|
| FDS4465 | FDS4465 | 13″ | 12 mm | 2500 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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